

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination ROUTLEY ET AL.	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0126073	09-2002	Knapp et al.	345/76
*	B	US-2001/0019327	09-2001	Kim et al.	345/204
	C	US-			
	D	US-			
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**FOREIGN PATENT DOCUMENTS**

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